## Search Notes

| Application/Control No. | Applicant(s)/Patent under Reexamination |
|---|---|
| 10/679,948 | TANAKA, SHUICHI |
| **Examiner** | **Art Unit** |
| Paul D. Kim | 3729 |

### SEARCHED

| Class | Subclass | Date | Examiner |
|---|---|---|---|
| 29 | 592.1<br>602.1<br>831<br>835<br>846<br>854<br>871-873 | 6/7/2006 | PK |
| 349 | 149-152 | | |
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### INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|---|---|---|---|
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| PGPub Text Search<br>see attachment | | 8/17/2006 | PK |

### SEARCH NOTES (INCLUDING SEARCH STRATEGY)

| | DATE | EXMR |
|---|---|---|
| Text Search<br>EAST/NPL (IEEE) | 6/7/2006 | PK |
| Updated<br>Text Search<br>EAST/PGPub | 8/17/2006 | PK |
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